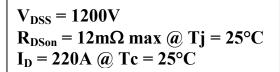
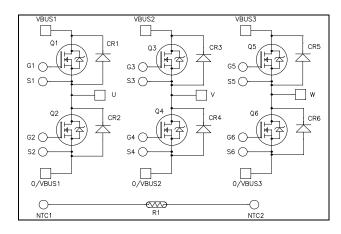
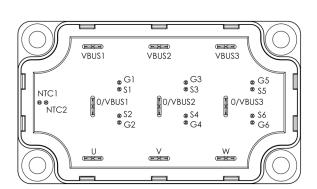


### Triple phase leg SiC MOSFET Power Module







#### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss
- SiC Schottky Diode
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature Independent switching behavior
  - Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS Compliant**

All ratings @  $T_j = 25$ °C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



#### **Absolute maximum ratings** (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1200	V
T	Continuous Drain Current	$T_c = 25^{\circ}C$	220	
$I_D$	Continuous Drain Current	$T_c = 80^{\circ}C$	165	Α
$I_{DM}$	Pulsed Drain current		440	
$V_{GS}$	Gate - Source Voltage		-10/25V	V
$R_{DSon}$	Drain - Source ON Resistance		12	mΩ
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	925	W

### **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 1200V$				300	μA
D	Dunin Common on Designation of	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		8	12	
$R_{DS(on)}$	Drain – Source on Resistance	$I_{\rm D} = 150 A$	$T_{j} = 150^{\circ}C$		14	21	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 30 \text{mA}$			2.4		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.8	μΑ

### **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Test Conditions			Max	Unit	
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$	$V_{GS} = 0V$ $V_{DS} = 1000V$		8.4			
$C_{oss}$	Output Capacitance	$V_{\rm DS} = 1000V$			0.66		nF	
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			0.045			
$Q_{g}$	Total gate Charge	$V_{GS} = -5/+20V$			483			
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 800V$			138		nC	
$Q_{gd}$	Gate – Drain Charge	$I_{\rm D} = 150 A$			150			
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$			35			
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 800V$		40				
$T_{d(off)}$	Turn-off Delay Time	_ , ,	$I_D = 150A$ , $T_J = 150$ °C $R_L = 5.3\Omega$ ; $R_{Gext} = 6.7\Omega$				ns	
$T_{\mathrm{f}}$	Fall Time	$R_L = 5.3\Omega$ ; $R_{Gext} = 6$						
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150^{\circ}C$		3.3		- mJ	
$E_{\text{off}}$	Turn off Energy	$V_{Bus} - 600V$ $I_D = 150A$ $R_{Gext} = 6.7\Omega$ $T_j = 150^{\circ}C$			1.8		IIIJ	
$R_{\text{Gint}}$	Internal gate resistance				2		Ω	
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	ce				0.135	°C/W	

### **Source - Drain diode ratings and characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 75A$		3.3		V
$ m V_{SD}$	Diode Folward Voltage	$V_{GS} = -2V, I_{SD} = 75A$		3.1		V
t <sub>rr</sub>	Reverse Recovery Time	$I_{SD} = 150A$ ; $V_{GS} = -5V$ $V_{R} = 800V$ ; $di_{F}/dt = 3000A/\mu s$		45		ns
Q <sub>rr</sub>	Reverse Recovery Charge			1.2		μC
$I_{rr}$	Reverse Recovery Current			40		Ā



# SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Condition	Min	Тур	Max	Unit	
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
$I_{RRM}$	Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25$ °C		100	515	μΑ
*KKWI	reverse Deakage Carrent	, K 1200 ,	$T_j = 175$ °C		483	1920	pu. 1
$I_F$	DC Forward Current		Tc = 125°C		50		A
V	Diode Forward Voltage	I - 50 A	$T_i = 25$ °C		1.6	1.8	V
$V_{\mathrm{F}}$		$I_F = 50A$	$T_i = 175^{\circ}C$		2.3	2.7	v
Qc	Total Capacitive Charge	$I_F = 50A, V_R = di/dt = 500A/\mu s$		170		nC	
С	Total Capacitance	$f = 1MHz, V_R = 200V$			320		рE
C	Total Capacitance	$f = 1MHz, V_R = 400V$			230		pF
$R_{thJC}$	Junction to Case Thermal Resistance		•			0.45	°C/W

#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

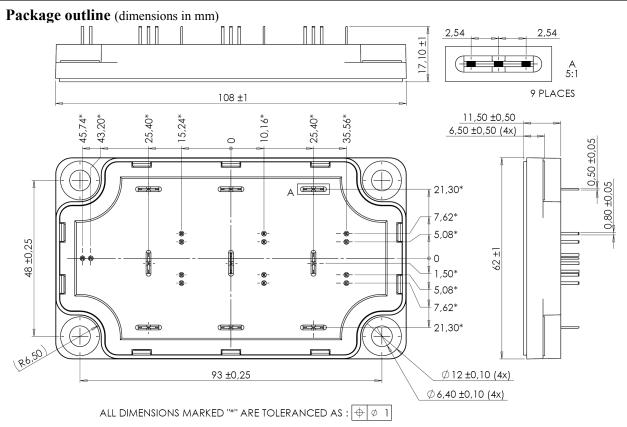
Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

### Thermal and package characteristics

Symbol	Characteristic	Min	Max	Unit		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t	=1 min, 50/60H	z	4000		V
Т	SiC MOSFET		-40	150		
$T_{J}$	Operating junction temperature range	ode	-40	175		
$T_{JOP}$	Recommended junction temperature under swi	Recommended junction temperature under switching conditions				
$T_{STG}$	Storage Temperature Range	-40	125			
$T_{\rm C}$	Operating Case Temperature	g Case Temperature				
Torque	Mounting torque	To heatsink	M6	3	5	N.m
Wt	Package Weight				250	g

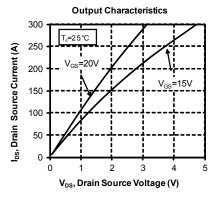


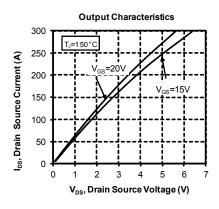


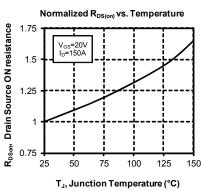
See application note 1902 - Mounting Instructions for SP6-P (12mm) Power Modules on www.microsemi.com

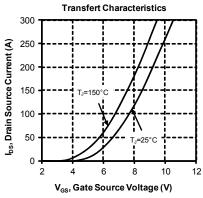


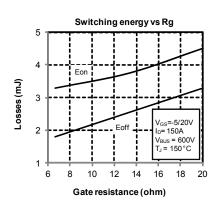
### **Typical SiC MOSFET Performance Curve**

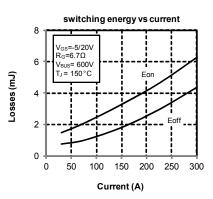


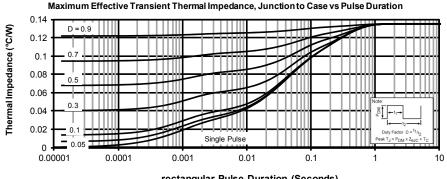








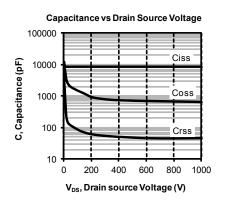


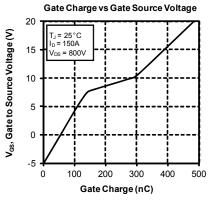


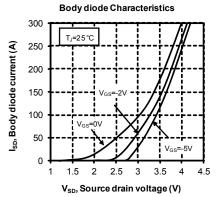
rectangular Pulse Duration (Seconds)

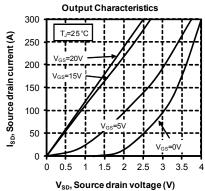
5 - 8

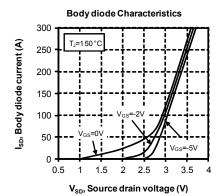


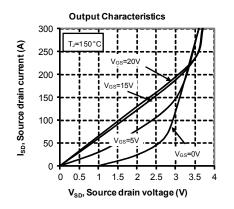


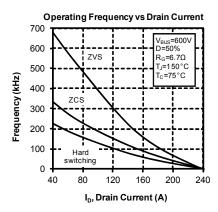












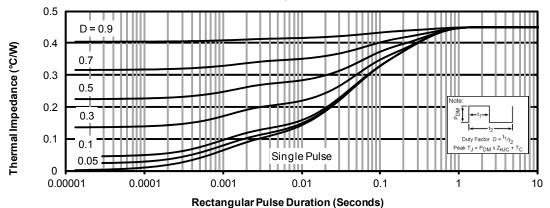
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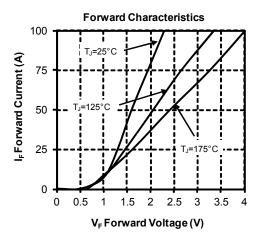


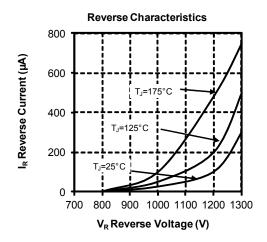
### Typical SiC diode Performance Curve

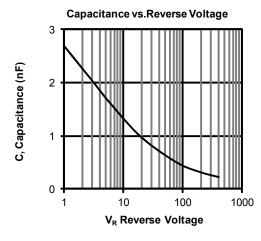
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



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25.330.4753.1 25.3	330.5253.1	25.334.3253.1	25.334.3353.1	25.350.2053.0	25.352.4753.1	25.522.3253.0	<u>T483C</u> <u>T484C</u>	<u>T485F</u> <u>T485H</u>
T512F-YEB T513	F T514F T	554 <u>T612FSE</u>	25.161.3453.0	25.179.2253.0	25.194.3253.0	25.325.1253.1	25.326.4253.1	25.330.0953.1
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